

# PHM30NQ10T

TrenchMOS™ standard level FET

Rev. 02 — 11 September 2003

Product data

## 1. Product profile

### 1.1 Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™ technology.

### 1.2 Features

- SOT96 (SO-8) footprint compatible
- Surface mounted package
- Low thermal resistance
- Low profile.

### 1.3 Applications

- DC-to-DC primary side
- Portable equipment applications.

### 1.4 Quick reference data

- $V_{DS} \leq 100 \text{ V}$
- $I_D \leq 37.6 \text{ A}$
- $P_{tot} \leq 62.5 \text{ W}$
- $R_{DSon} \leq 20 \text{ m}\Omega$

## 2. Pinning information

Table 1: Pinning - SOT685 (QLPAK), simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1,2,3	source (s) <span style="color: red;">[1]</span>	<p>Bottom view <span style="float: right;">MBL585</span></p>	<p style="text-align: center;">MBB076</p>
4	gate (g)		
5,6,7,8	drain (d)		
mb	mounting base, connected to drain (d)		

**SOT685-1 (QLPAK)**

[1] Shaded area indicates terminal 1 index area.



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### 3. Ordering information

**Table 2: Ordering information**

Type number	Package		Version
	Name	Description	
PHM30NQ10T	QLPAK	Plastic surface mounted package; no leads; 8 terminals.	SOT685

### 4. Limiting values

**Table 3: Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	100	V
$V_{DGR}$	drain-gate voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$ ; $R_{GS} = 20\text{ k}\Omega$	-	100	V
$V_{GS}$	gate-source voltage (DC)		-	$\pm 20$	V
$I_D$	drain current (DC)	$T_{mb} = 25\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; <b>Figure 2 and 3</b>	-	37.6	A
		$T_{mb} = 100\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; <b>Figure 2</b>	-	23.8	A
$I_{DM}$	peak drain current	$T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; <b>Figure 3</b>	-	60	A
$P_{tot}$	total power dissipation	$T_{mb} = 25\text{ °C}$ ; <b>Figure 1</b>	-	62.5	W
$T_{stg}$	storage temperature		-55	+150	°C
$T_j$	junction temperature		-55	+150	°C

#### Source-drain diode

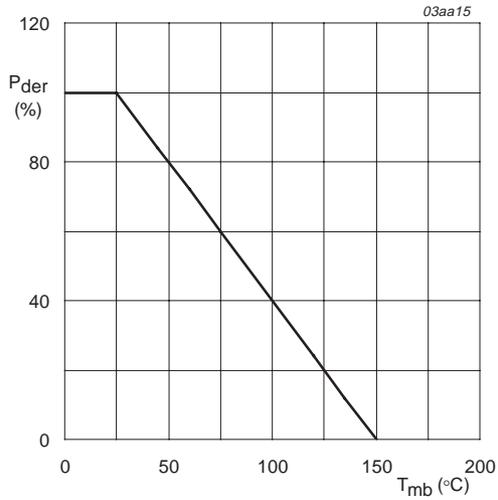
$I_S$	source (diode forward) current (DC)	$T_{mb} = 25\text{ °C}$	-	37.6	A
$I_{SM}$	peak source (diode forward) current	$T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$	-	60	A

#### Avalanche ruggedness

$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; $I_D = 14.2\text{ A}$ ; $t_p = 0.31\text{ ms}$ ; $V_{DD} \leq 100\text{ V}$ ; $R_{GS} = 50\text{ }\Omega$ ; $V_{GS} = 10\text{ V}$ ; starting $T_j = 25\text{ °C}$	-	350	mJ
$E_{DS(AL)R}$	repetitive drain-source avalanche energy	unclamped inductive load; $I_D = 1.4\text{ A}$ ; $t_p = 0.031\text{ ms}$ ; $V_{DD} \leq 100\text{ V}$ ; $R_{GS} = 50\text{ }\Omega$ ; $V_{GS} = 10\text{ V}$	[1] - [2]	3.5	mJ

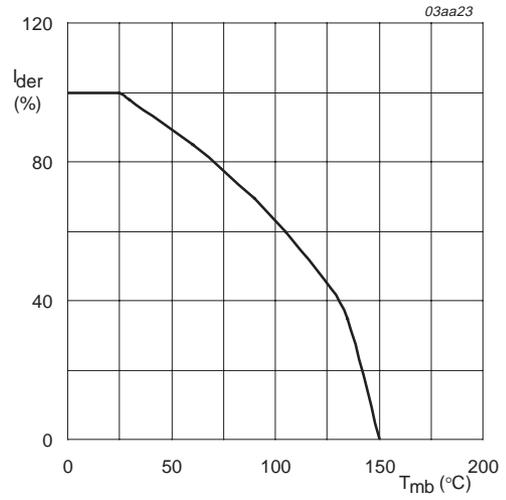
[1] Duty cycle limited by maximum junction temperature.

[2] Repetitive avalanche failure is not determined simply by thermal effects. Repetitive avalanche transients should only be applied for short bursts, not every switching cycle.



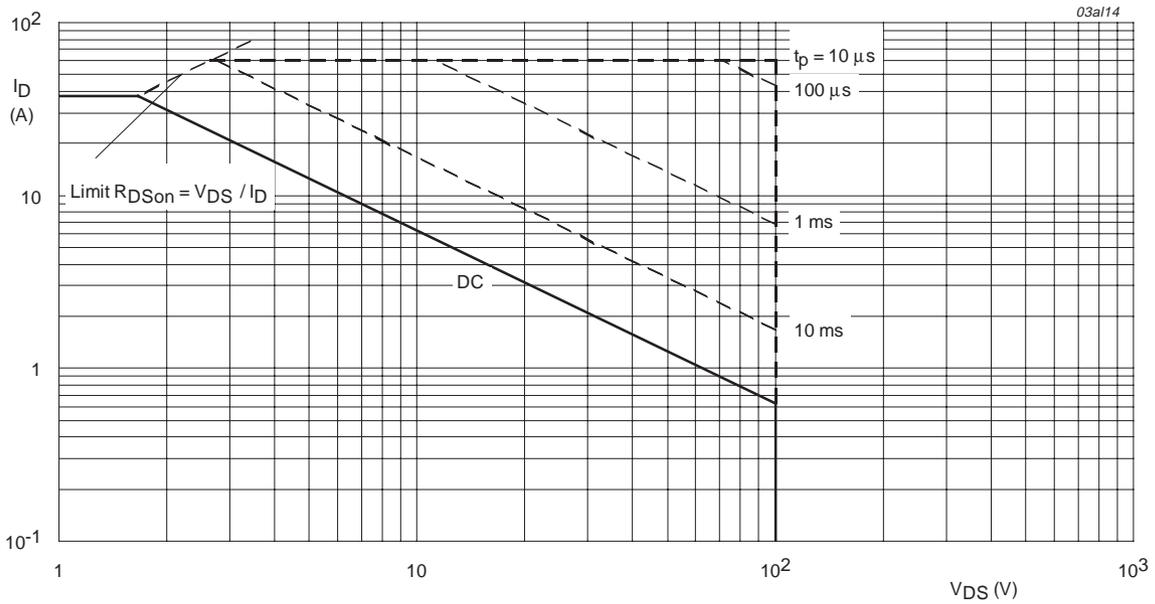
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



$T_{mb} = 25^{\circ}C$ ;  $I_{DM}$  is single pulse;  $V_{GS} = 10V$

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

## 5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	-	-	2	K/W

### 5.1 Transient thermal impedance

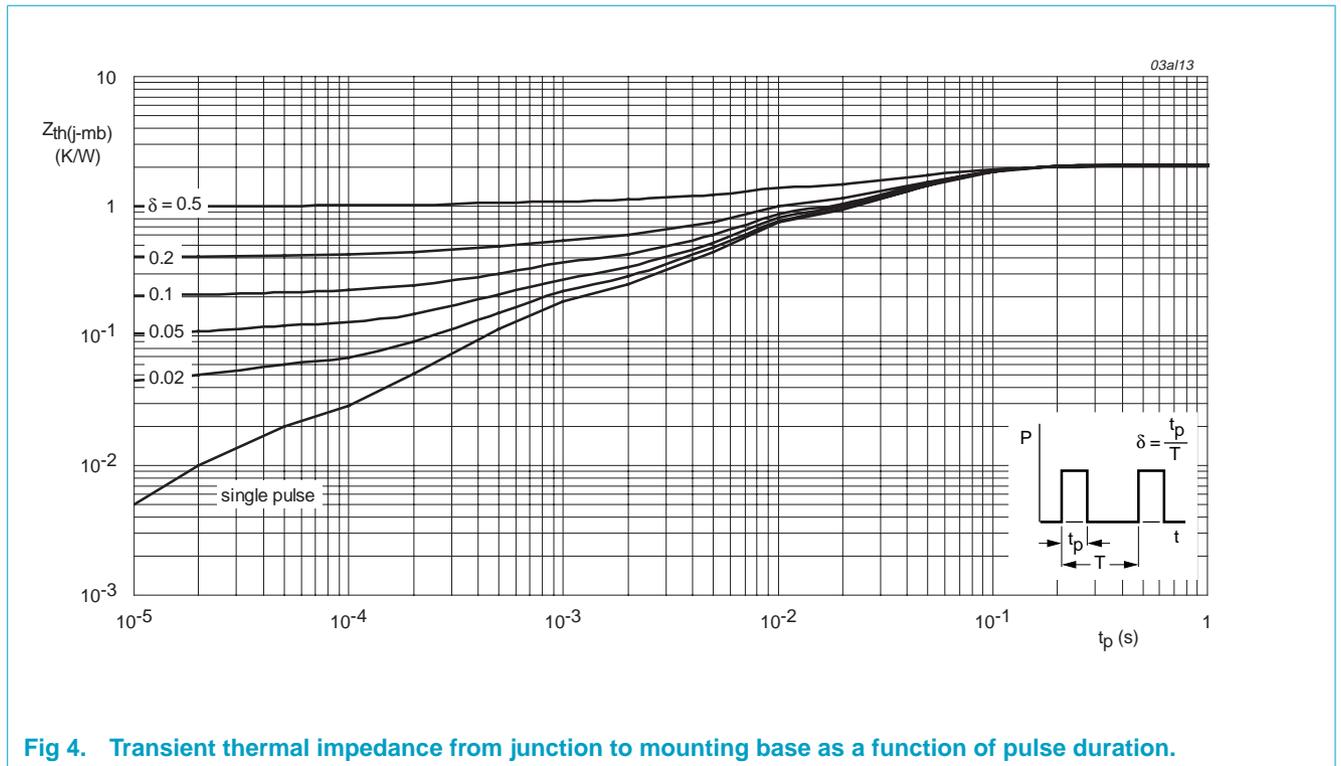
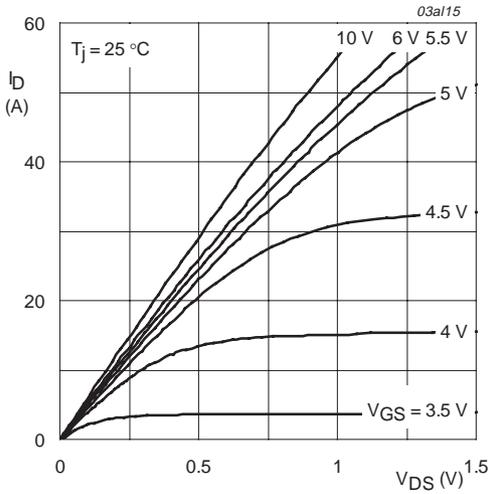


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

## 6. Characteristics

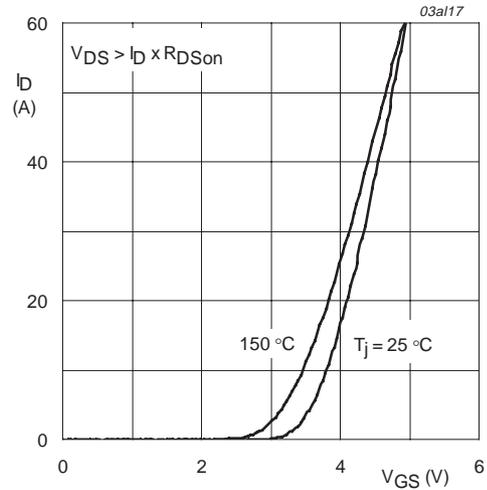
**Table 5: Characteristics**
 $T_j = 25\text{ °C}$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250\ \mu\text{A}$ ; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ °C}$	100	-	-	V
		$T_j = -55\text{ °C}$	89	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1\ \text{mA}$ ; $V_{DS} = V_{GS}$ ; <b>Figure 9</b> $T_j = 25\text{ °C}$	2	3	4	V
		$T_j = 150\text{ °C}$	1.2	-	-	V
		$T_j = -55\text{ °C}$	-	-	4.4	V
$I_{DSS}$	drain-source leakage current	$V_{DS} = 80\ \text{V}$ ; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ °C}$	-	-	1	$\mu\text{A}$
		$T_j = 150\text{ °C}$	-	-	100	$\mu\text{A}$
$I_{GSS}$	gate-source leakage current	$V_{GS} = \pm 20\ \text{V}$ ; $V_{DS} = 0\ \text{V}$	-	10	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\ \text{V}$ ; $I_D = 18\ \text{A}$ ; <b>Figure 7 and 8</b> $T_j = 25\text{ °C}$	-	17	20	m $\Omega$
		$T_j = 150\text{ °C}$	-	37.4	44	m $\Omega$
<b>Dynamic characteristics</b>						
$Q_{g(tot)}$	total gate charge	$I_D = 25\ \text{A}$ ; $V_{DD} = 50\ \text{V}$ ; $V_{GS} = 10\ \text{V}$ ; <b>Figure 13</b>	-	53.7	-	nC
$Q_{gs}$	gate-source charge		-	13.2	-	nC
$Q_{gd}$	gate-drain (Miller) charge		-	11.5	-	nC
$C_{iss}$	input capacitance	$V_{GS} = 0\ \text{V}$ ; $V_{DS} = 25\ \text{V}$ ; $f = 1\ \text{MHz}$ ; <b>Figure 11</b>	-	3600	-	pF
$C_{oss}$	output capacitance		-	430	-	pF
$C_{rss}$	reverse transfer capacitance		-	140	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DD} = 50\ \text{V}$ ; $R_L = 56\ \Omega$ ; $V_{GS} = 10\ \text{V}$ ; $R_G = 5.6\ \Omega$	-	21	-	ns
$t_r$	rise time		-	11	-	ns
$t_{d(off)}$	turn-off delay time		-	77	-	ns
$t_f$	fall time		-	51	-	ns
<b>Source-drain diode</b>						
$V_{SD}$	source-drain (diode forward) voltage	$I_S = 18\ \text{A}$ ; $V_{GS} = 0\ \text{V}$ ; <b>Figure 12</b>	-	0.91	1.2	V
$t_{rr}$	reverse recovery time	$I_S = 10\ \text{A}$ ; $di_S/dt = -100\ \text{A}/\mu\text{s}$ ; $V_{GS} = 0\ \text{V}$	-	100	-	ns
$Q_r$	recovered charge		-	125	-	nC



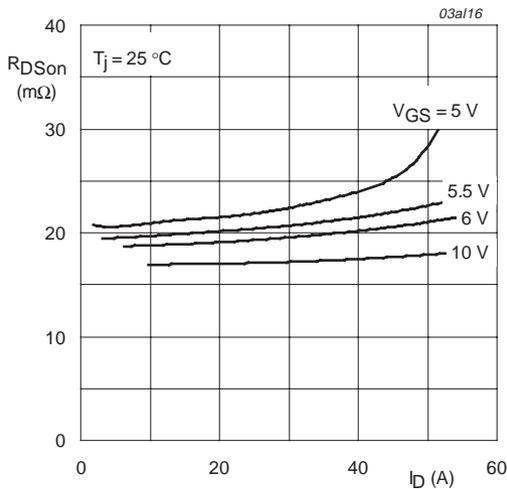
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



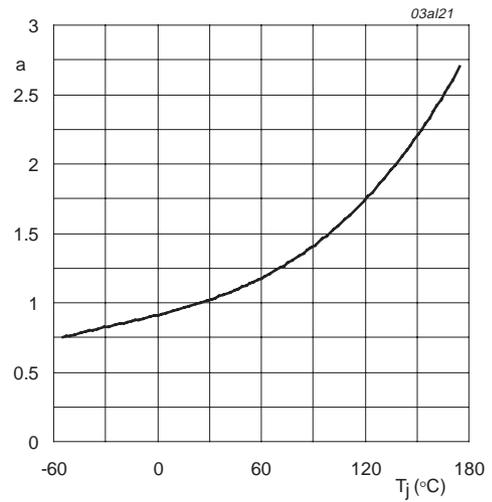
$T_j = 25\text{ }^\circ\text{C}$  and  $150\text{ }^\circ\text{C}$ ;  $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



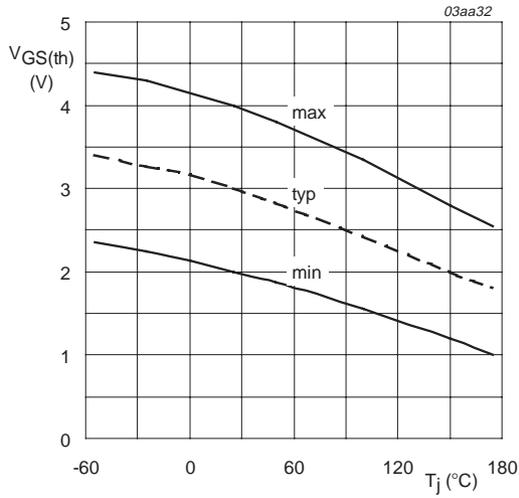
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



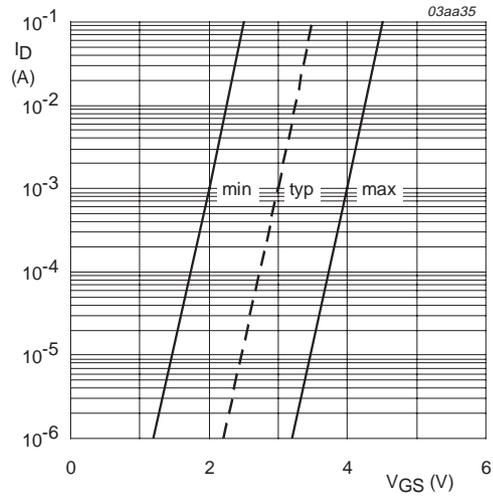
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



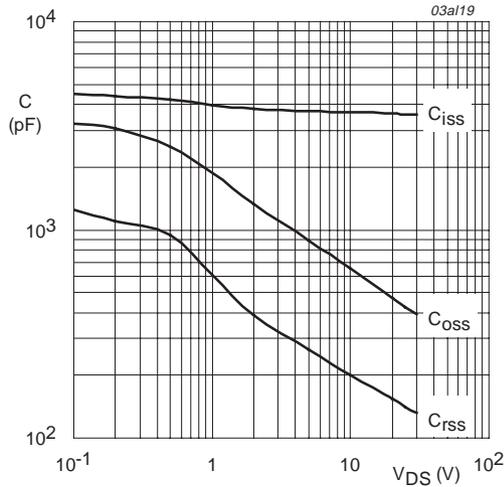
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

**Fig 9. Gate-source threshold voltage as a function of junction temperature.**



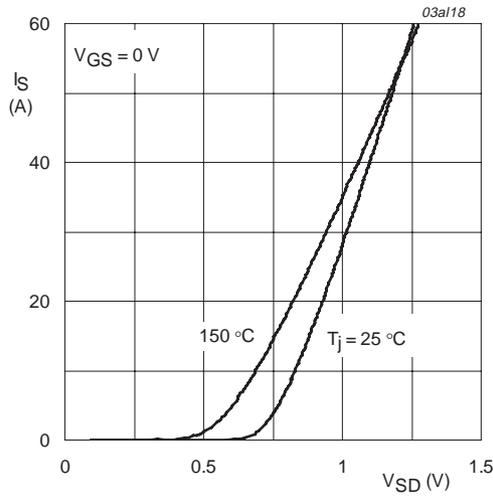
$T_j = 25 \text{ °C}$

**Fig 10. Sub-threshold drain current as a function of gate-source voltage.**



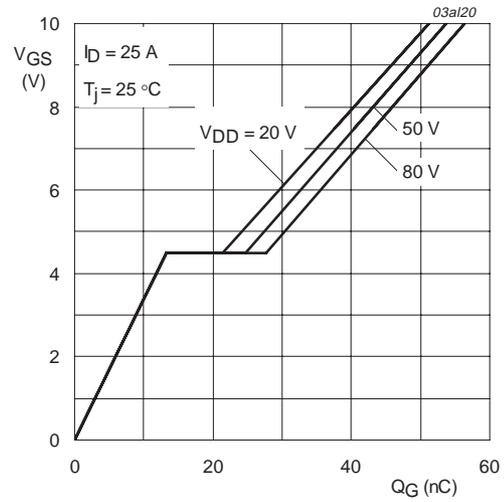
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

**Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.**



$T_j = 25$  °C and  $150$  °C;  $V_{GS} = 0$  V

**Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.**



$I_D = 25$  A;  $V_{DD} = 20$  V,  $50$  V,  $80$  V

**Fig 13. Gate-source voltage as a function of gate charge; typical values.**

7. Package outline

HVSON8: plastic thermal enhanced very thin small outline package; no leads; 8 terminals; body 6 x 5 x 0.85 mm

SOT685-1

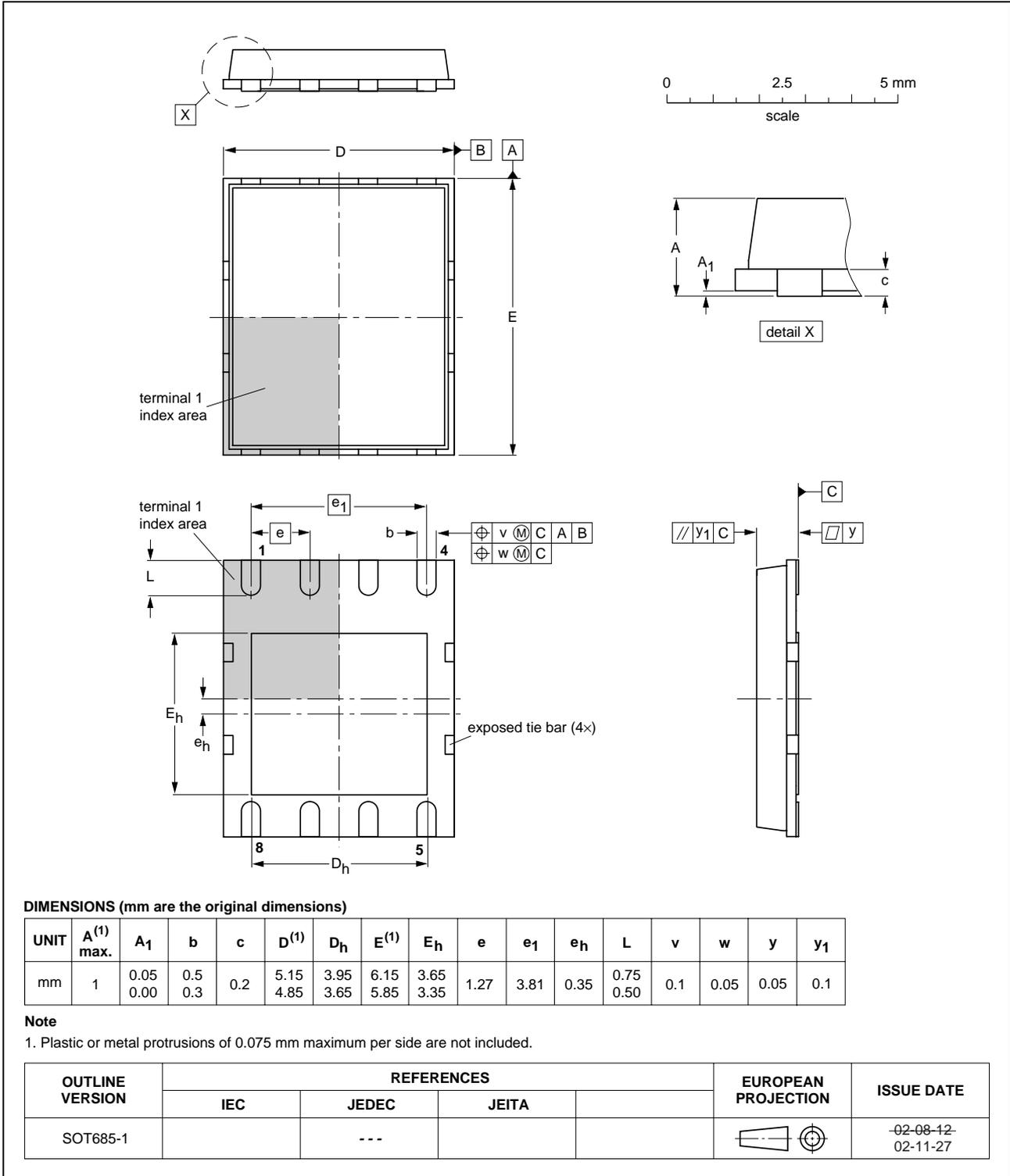
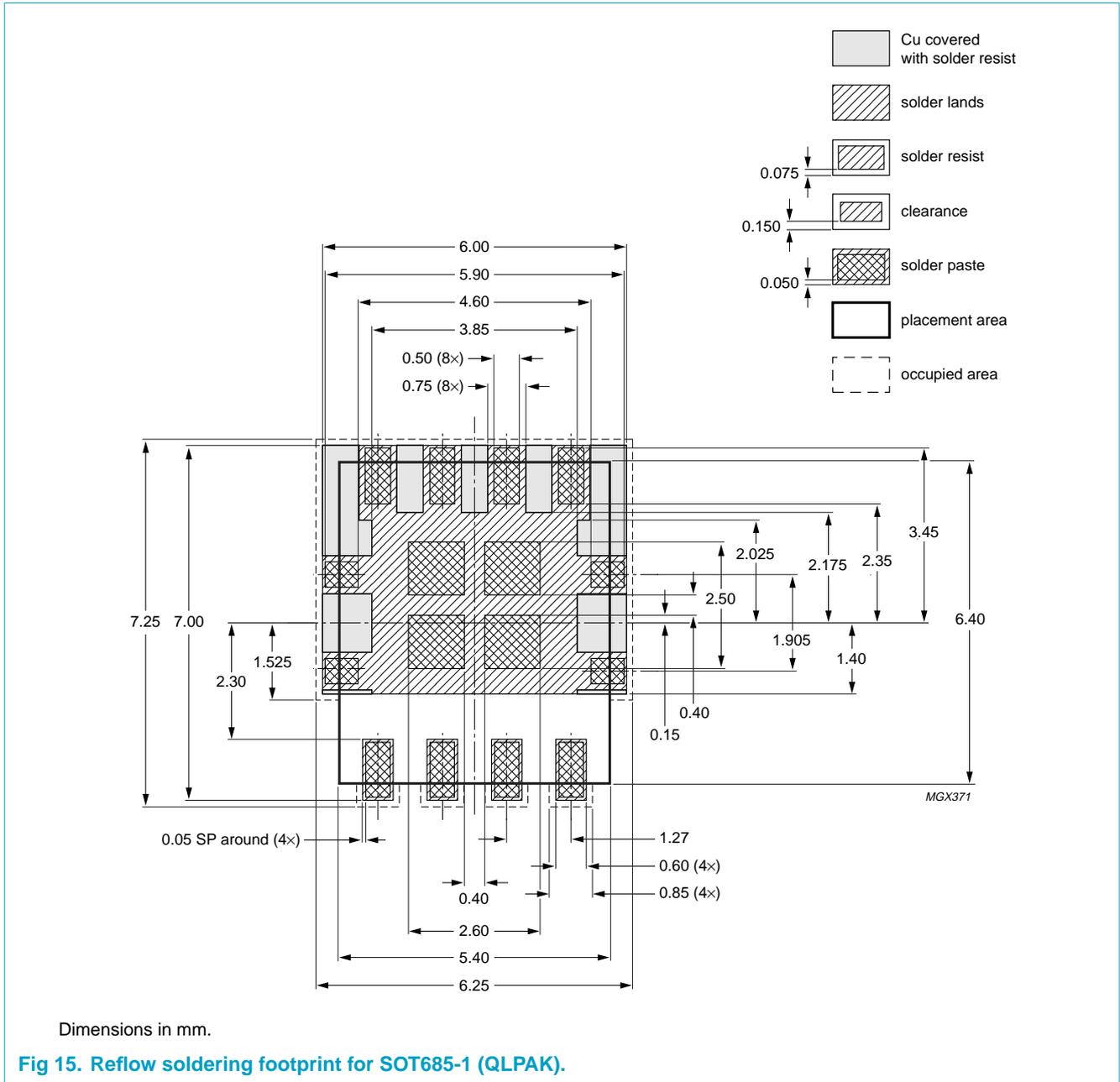


Fig 14. SOT685-1 (QLPAK).

8. Soldering



## 9. Revision history

Table 6: Revision history

Rev	Date	CPCN	Description
02	20030911		<b>Product data (9797 750 11842)</b> Modifications: <ul style="list-style-type: none"><li>• <b>Section 3 “Ordering information”</b> Addition of ordering information.</li><li>• <b>Section 4 “Limiting values”</b> Addition of <math>E_{DS(AL)S}</math>.</li><li>• <b>Section 4 “Limiting values”</b> Addition of <math>E_{DS(AL)R}</math>.</li><li>• <b>Section 8 “Soldering”</b> Addition of soldering footprint.</li></ul>
01	20030129	-	<b>Preliminary data (9397 750 10879)</b>

## 10. Data sheet status

Level	Data sheet status <sup>[1]</sup>	Product status <sup>[2][3]</sup>	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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